Single vortices observed as they enter N b Se2

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A bstract

We observe single vortices as they penetrate the edge of a superconductor using a high-sensitivity magneto-optical microscope. The vortices leap across a gap near the edge, a distance that decreases with increasing appliedeld and sample thickness. This behaviour can be explained by the combinedeldect of the geometrical barrier and bulk pinning.

Key words: Vortex dynamics, edge penetration, surface barrier, magneto-optical imaging PACS: 74.60.Ge

1. Introduction

As vortices enter a superconductor, their motion is determined by the complex interplay between several competing forces: the Lorentz force from the shielding currents tends to drag them into the sample, pinning forces resist their motion, and nally they must overcome an edge barrier (the Bean-Livingston [1] barrier and the geometrical barrier [2]).

The resulting behaviour has been studied both theoretically and experimentally. It has been found that the forces near the edges can be a source of magnetic irreversibility even in the absence of bulk pinning [2], and can control the transport current distribution ([3], [4]).

In this paper we report direct m agneto-optical (M \circ) observations of individual vortex m otion near a superconductor's edge.

2. M ethod

We have used a magneto-optical microscope capable of resolving single vortices to look at the detailed ux

dynam ics near the edge for two sam ples of N bSe2. The basic principle of the method is to let polarised light pass through a magneto-optical indicator lm placed close to the sam ple surface, and then detect changes in the polarisation. The instrument is further described in [5]. For single vortex resolution the MO lm must be very close to the sam ple, because at larger distances the single vortex eld quickly becomes smeared out.

The eld penetration experiments were performed on two NbSe2 single crystals [6] with thickness 100 m and 10 m. The sample shape was approximately a rectangle with the smallest dimension $1\,\mathrm{m\,m}$. The samples were initially cooled to 5 K in a residual eld of 0.05 m T . A fter cooling, an external eld H $_\mathrm{a}$ was applied perpendicular to the plane of the sample and ramped from 0 to 1 m T .

3.0 bservations

Figure 1 shows snapshots of vortex penetration into the 100 m thick sample. Individual vortices are clearly seen as they enter the sample. But we also see that near the edge of the sample a vortex free band exists, approximately 5 m wide. When a vortex enters the sample, it jumps across the band and gets pinned. When observing the vortex entry over a wider eld range,

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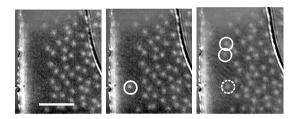


Figure 1.M O im ages showing vortex penetration in a 100 m thick NbSe2 crystal. The applied eld is $0.2\,\text{m}$ T and increases slightly from left to right. In the second image a vortex has appeared, marked with a white circle. In the third two more have appeared, while the set one has moved slightly. A wide vortex free band is seen between the edge (a narrow bright band on the left) and the vortex-lled region. The scalebar is 10° m :

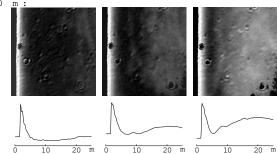


Figure 2.M O im ages showing vortex penetration in a 10 m thick N bSe2 crystal at applied elds of 0.1, 0.5 and 1.0 m T (left to right). The sample edge is seen as a bright line on the left. As the eld increases, the ux front is moving towards the edge, and the ux free zone near the edge shrinks. The graphs underneath show pro les of ux density obtained from the im ages by averaging gray level in each pixel column.

we see that the band remains (albeit thinning a bit as the eld increases) as more vortices penetrate, while the vortex density increases beyond the band. A full movie of vortex penetration during the eld ramp can be found at http://www.fys.uio.no/super/results/sv.

Figure 2 shows eld distributions for the thin sam ple. Because of larger distance between the sam ple and the M O lm , individual ux quanta cannot be seen here. However, the gray levels still represent the actual ux density. We have plotted proles of ux density underneath the images by averaging the gray-levels column by-column. For this sample we also see a vortex free band near the sample edge. The band width is again eld dependent, but it is much larger than for the thick sample at the same H $_{\rm a}$.

4. D iscussion

Both sam ples show a vortex free band near the edge. When vortices enter the sample, they move quickly through this band and get pinned some distance x from the edge. The three main observations to be explained are: (i) the band is shrinking as the eld increases, (ii) the band is wider for the thinner sample, (iii) there is a

narrow bright band at the edge. A llthese observations can be explained by the combined e ect of the geom etrical barrier and bulk pinning [2], [7]. A physical picture of the vortex entry process is the following: there is an energy cost associated with vortex form ation at a superconductor's edge. Once the barrier due to this energy is overcome, the vortex is pushed inwards by the M eissner current. The M eissner force decays as the vortex gets deeper so at some point it is balanced by the pinning force, and the vortex stops. The pinning force is larger for the thicker sample, so qualitatively this is consistent with our observation (ii) above.

Finally, the bright band of high ux density near the sam ple edge can be explained by a build up of partially penetrated vortices \clim bing" the geom etrical barrier. In fact, individual vortices constituting this band can be resolved at low elds. However, the width of this barrier is thought to be of the order of the sam ple thickness [2], while we observe a much lower width of the band (3 m) that is the sam e for both sam ples.

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